

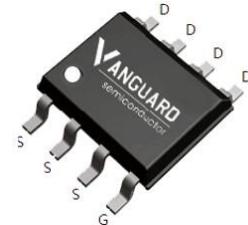
Features

- N-Channel, 5V Logic Level Control
- Enhancement mode
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5\text{ V}$
- Fast Switching
- Pb-free lead plating; RoHS compliant
- MSL: Level 1 compliant

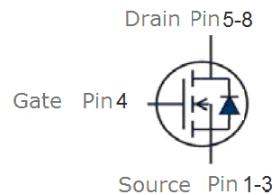


V_{DS}	60	V
$R_{DS(on),TYP}$ @ $V_{GS}=10\text{ V}$	9.5	$\text{m}\Omega$
$R_{DS(on),TYP}$ @ $V_{GS}=4.5\text{ V}$	11.5	$\text{m}\Omega$
I_D	13	A

SOP8



Part ID	Package Type	Marking	Tape and reel information
VSO012N06MS	SOP8	012N06M	3000pcs/Reel



Maximum ratings, at $T_A=25\text{ }^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	60	V
V_{GS}	Gate-Source voltage	± 20	V
I_S	Continuous Source Current (Body Diode)	$T_A = 25\text{ }^\circ\text{C}$	A
I_{SM}	Maximum Pulsed Current (Body Diode)	$T_A = 25\text{ }^\circ\text{C}$	A
I_D	Continuous drain current @ $V_{GS}=10\text{ V}$	$T_A = 25\text{ }^\circ\text{C}$	A
		$T_A = 100\text{ }^\circ\text{C}$	A
I_{DM}	Pulse drain current tested ①	$T_A = 25\text{ }^\circ\text{C}$	A
I_{AS}	Avalanche Current maximum	55	A
E_{AS}	Avalanche energy, single pulsed ②	1229	mJ
P_D	Maximum power dissipation	$T_A = 25\text{ }^\circ\text{C}$	W
T_{STG}, T_J	Storage and Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Lead	24	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	40	$^\circ\text{C/W}$



Vanguard
Semiconductor

VSO012N06MS
60V/13A N-Channel Advanced Power MOSFET

Typical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	60	--	--	V
$\Delta V_{(\text{BR})\text{DSS}} / \Delta T_j$	Breakdown voltage Temperature Coefficient	$I_{\text{D}}=250\mu\text{A}$, Reference 25°C	--	0.052	--	$^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current($T_j=25^\circ\text{C}$)	$V_{\text{DS}}=60\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_j=125^\circ\text{C}$)	$V_{\text{DS}}=60\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.4	1.8	2.5	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ⁽³⁾	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=8\text{A}$	--	9.5	12	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ⁽³⁾	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=4\text{A}$	--	11.5	14	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
R_g	Gate Resistance	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	--	2.8	--	Ω
C_{iss}	Input Capacitance		--	1905	--	pF
C_{oss}	Output Capacitance		--	205	--	pF
C_{rss}	Reverse Transfer Capacitance		--	180	--	pF
Q_g	Total Gate Charge	$V_{\text{DS}}=30\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=10\text{V}$	--	26	--	nC
Q_{gs}	Gate-Source Charge		--	6.5	--	nC
Q_{gd}	Gate-Drain Charge		--	4.5	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=30\text{V}, I_{\text{D}}=10\text{A}, R_{\text{G}}=6.8\Omega, V_{\text{GS}}=10\text{V}$	--	9	--	ns
t_r	Turn-on Rise Time		--	5	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	28	--	ns
t_f	Turn-Off Fall Time		--	4	--	ns
Source- Drain Diode Characteristics@ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=2\text{A}, V_{\text{GS}}=0\text{V}$	--	0.71	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{SD}}=10\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=100\text{A}/\mu\text{s}$	--	23	--	ns
Q_{rr}	Reverse Recovery Charge		--	52	--	nC

NOTE:

- ⁽¹⁾ Repetitive rating; pulse width limited by max junction temperature.
- ⁽²⁾ Limited by $T_{j\text{max}}$, starting $T_j = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 55\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value
- ⁽³⁾ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.



Vanguard
Semiconductor

VSO012N06MS

60V/13A N-Channel Advanced Power MOSFET

Typical Characteristics

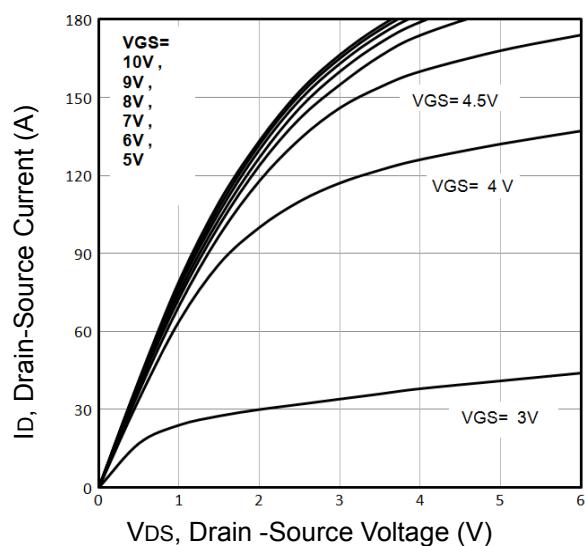


Fig1. Typical Output Characteristics

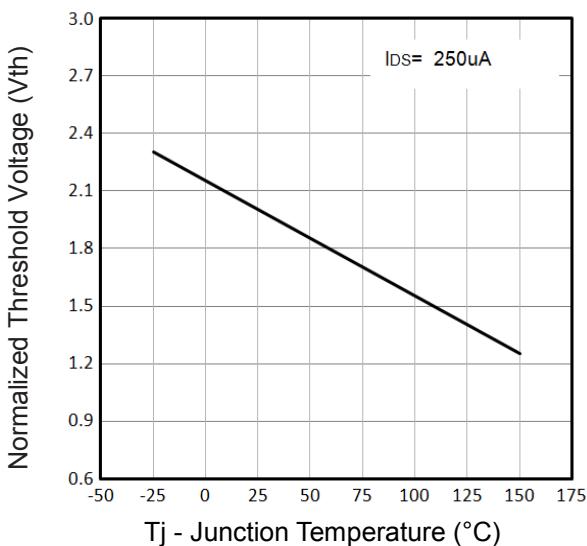


Fig2. Normalized Threshold Voltage Vs. Temperature

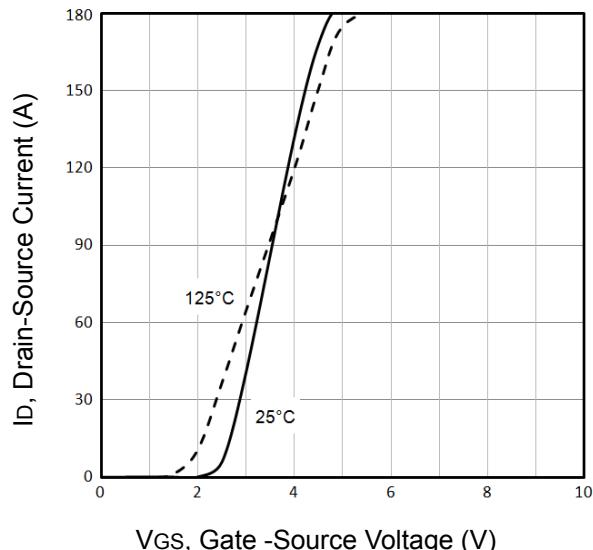


Fig3. Typical Transfer Characteristics

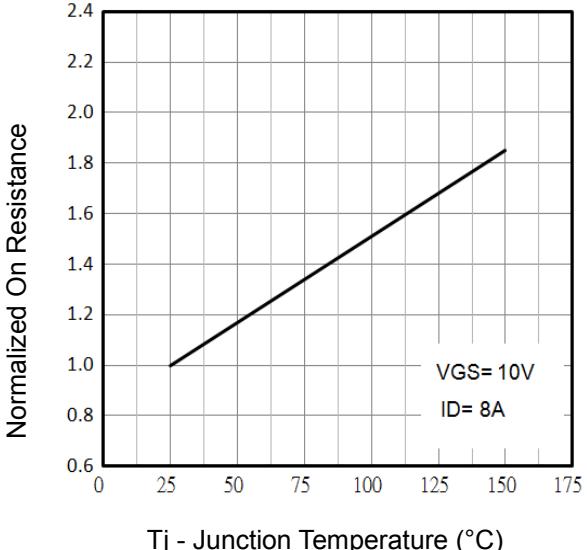


Fig4. Normalized On-Resistance Vs. Temperature

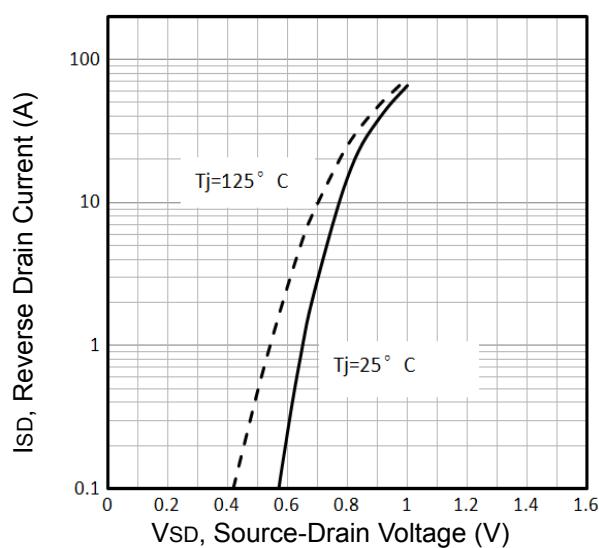


Fig5. Typical Source-Drain Diode Forward Voltage

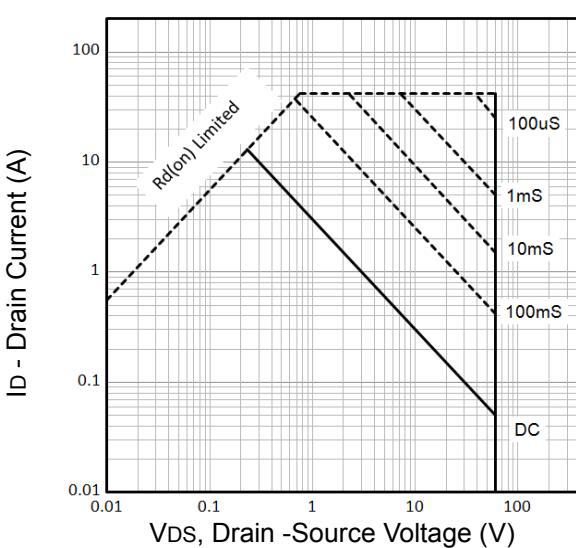


Fig6. Maximum Safe Operating Area



Vanguard
Semiconductor

VSO012N06MS
60V/13A N-Channel Advanced Power MOSFET

Typical Characteristics

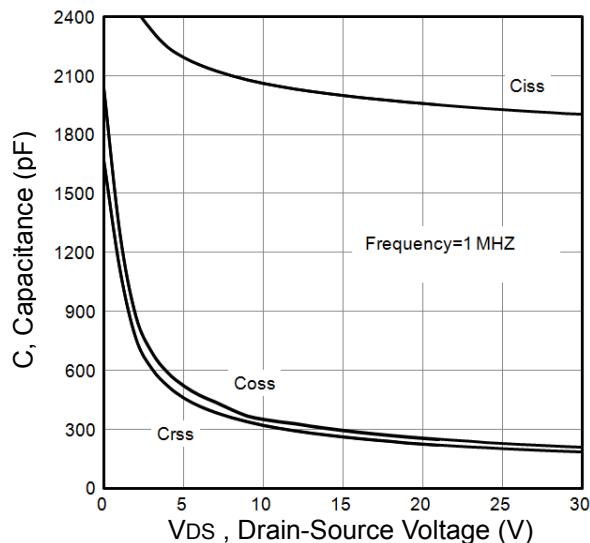


Fig7. Typical Capacitance Vs.Drain-Source Voltage

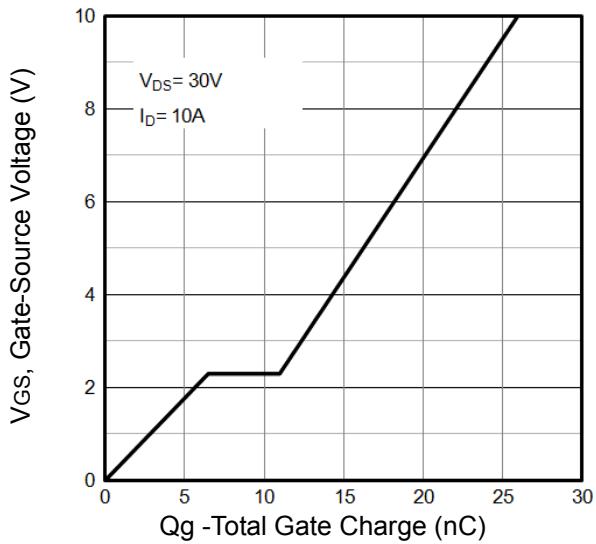


Fig8. Typical Gate Charge Vs.Gate-Source

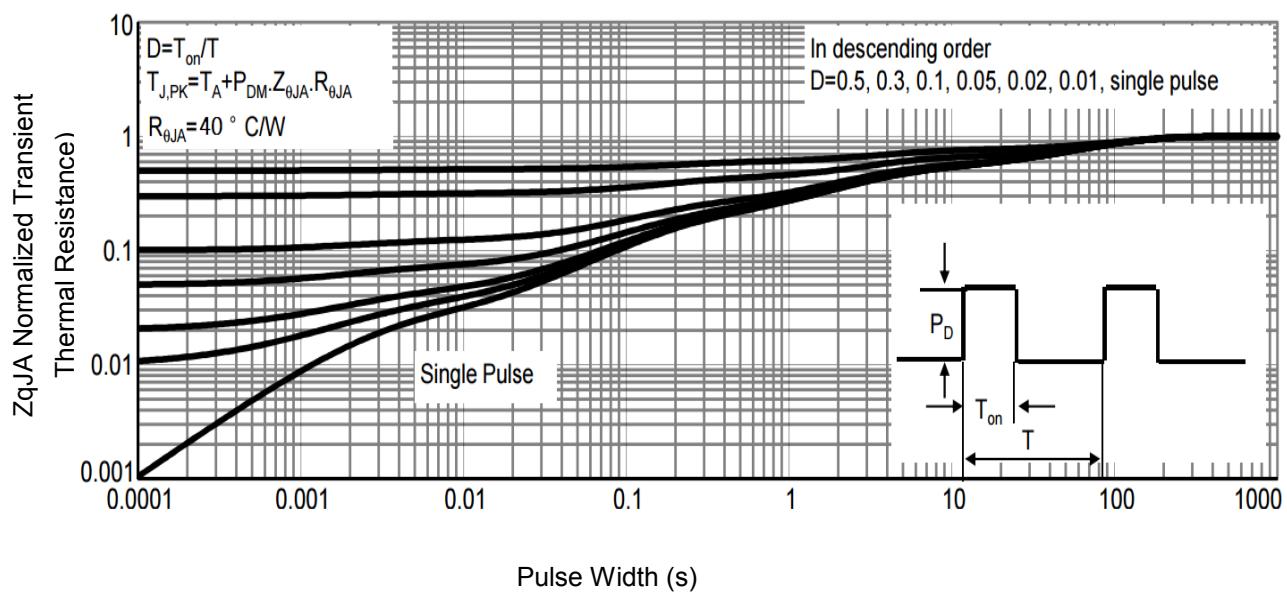


Fig9. Normalized Maximum Transient Thermal Impedance

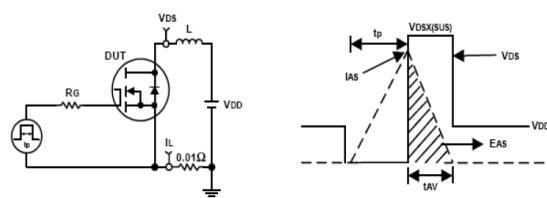


Fig10. Unclamped Inductive Test Circuit and waveforms

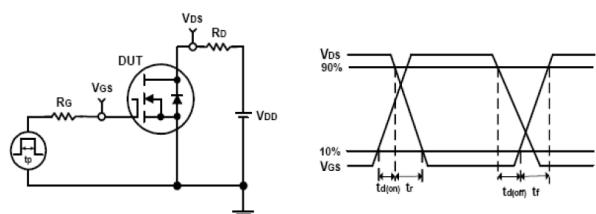
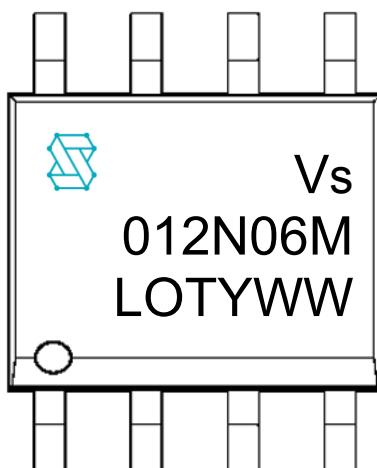


Fig11. Switching Time Test Circuit and waveforms

Marking Information



1st line: Vanguard Code (Vs), Vanguard Logo

2nd line: Part Number (012N06M)

3rd line: Date code (LOTYWW)

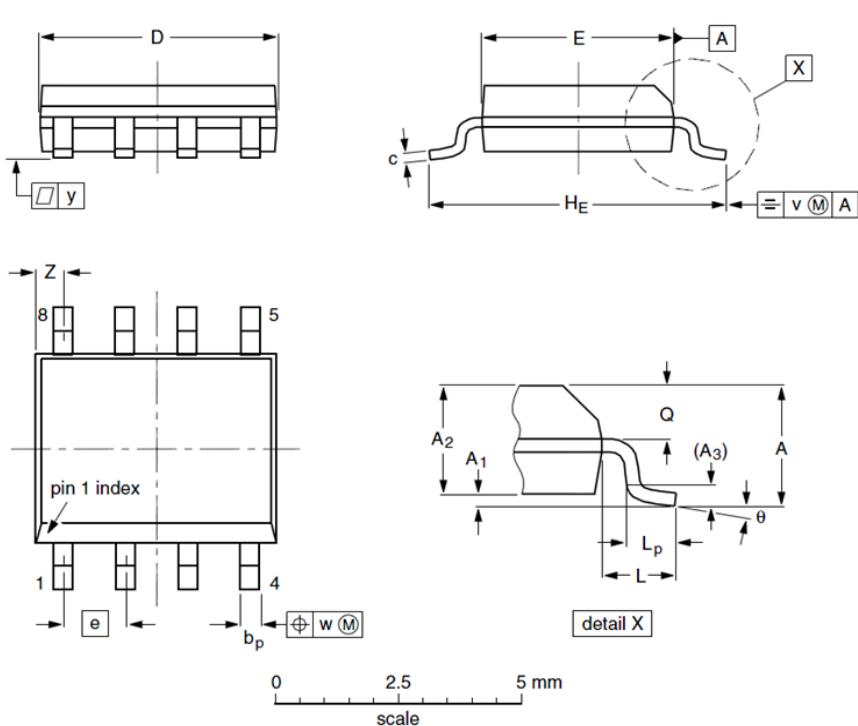
LOT: Wafer Lot Number

Y: Year Code, e.g. E means 2017

WW: Week Code



SOP8 Package Outline Data



Label	Dimensions (unit: mm)		
	Min	Typ	Max
A	--	--	1.75
A ₁	0.10	0.18	0.25
A ₂	1.25	1.35	1.50
A ₃	--	0.25	--
b _p	0.36	0.42	0.51
c	0.19	0.22	0.25
D	4.80	4.92	5.00
E	3.80	3.90	4.00
e	--	1.27	--
H _E	5.80	6.00	6.20
L	--	1.05	--
L _p	0.40	0.68	1.00
Q	0.60	0.65	0.725
v	--	0.25	--
w	--	0.25	--
y	--	0.10	--
Z	0.30	0.50	0.70
θ	0°		8°

Notes:

1. Follow JEDEC MS-012.
2. Dimension "D" does NOT include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.
3. Dimension "E" does NOT include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25mm per side.
4. Dimension "bp" does NOT include dambar protrusion. Allowable dambar protrusion shall be 0.1mm total in excess of "bp" dimension at maximum material condition. The dambar cannot be located on the lower radius of the foot.

Customer Service

Sales and Service:

sales@vgsemi.com

Vanguard Semiconductor CO., LTD

TEL: (86-755) -26902410

FAX: (86-755) -26907027

WEB: www.vgsemi.com